

<b>Notice of References Cited</b>	Application/Control No. 10/783,027		Applicant(s)/Patent Under Reexamination KOH ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0063528	04-2003	Ogikubo, Takahiko	369/30.24
*	C	US-2002/0135608	09-2002	Hamada et al.	345/723
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**NON-PATENT DOCUMENTS**

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